

# **Genera Description**

#### 概述

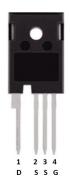
Specifically designed for Automotive applications, this SiC Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per unit area.

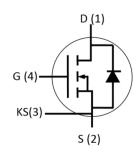
本产品是一款专为汽车应用设计的碳化硅功率MOSFET产品,采用了先进的工艺技术,产品的单位面积导通电阻非常低。

#### **Features**

#### 特点

- High Speed Switching with Low Capacitances
   开关速度快,寄生电容小
- High Blocking Voltage with Low R<sub>DS(on)</sub>
   阻断电压高,开通电阻低
- 100% avalanche tested100%通过雪崩测试
- Halogen Free and RoHS Compliant 无卤元素,符合 RoHS





# **Typical Applications**

典型应用

- EV Charging
  - EV充电
- DC-AC Inverters

DC-AC 转换器

• High Voltage DC/DC Converters

高压 DC/DC 变压器

• Power Factor Correction Modules

功率因素矫正模块

#### **Ordering Information**

订货信息

Type	BVDSS[V]	RDSon[mΩ]	Tjmax[℃]	Marking	Packing
型号	漏极-源极电压	导通电阻	最高结温	标记	封装外形
BSK040S120	1200	40	175	BSK040S120	TO247-4

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### **Maximum Rated Values**

# 最大额定参数

Parameter 参数	Symbol 符号	Value 数值	Unit 单位
Drain-Source Voltage, Tj≥25℃ 漏-源电压, Tj≥25℃	V <sub>DSS</sub>	1200	V
Drain Current(continuous)at T <sub>C</sub> =25℃ 常温下漏极电流(持续)	Ţ	60	
Drain Current(continuous)at T <sub>C</sub> =100℃ T <sub>C</sub> =100℃下漏极电流(持续)	$ I_{\mathrm{D}}$	40	A
Pulsed Drain current, tp limited by Tj max 集电极脉冲电流,脉宽时间受 Tj max 限制	$I_{D(pulse)}$	100	
Gate-Source Voltage 栅极-源极电压	V <sub>GSMAX</sub>	-10/+22	V
Gate-Source Voltage (Recommended operational values) 栅极-源极电压(推荐工作电压)	$ m V_{GS}$	-5/+18	V
Power Dissipation $T_C = 25$ °C 常温耗散功率	$P_{D}$	312	W
Storage Temperature Range 储存温度范围	$T_{ m J.Tstg}$	-55 to +175	
Solder Temperature, 1.6mm case from for 10s 焊接温度	$T_{ST}$	260	°C
Operating junction temperature Range 工作结温	T <sub>J</sub>	-55 to +175	
Mounting Torque 安装力矩	M <sub>d</sub>	1 8.8	Nm Ibf-in

Caution: These values must not be exceeded under any conditions.

注意: 任何条件下都不能超出上述值。

### **Thermal Resistance**

### 热阻

Parameter 参数	Symbol 符号	Value 值	Unit 单位
Thermal Resistance, Junction to Case, Max. 结-管壳热阻	$R_{ heta  m JC}$	0.48	°C/W
Thermal Resistance, Junction to Ambient, Max. 结-环境热阻	$R_{ heta JA}$	38	*C/W

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# Electrical Characteristic at Tj = 25°C (unless otherwise specified) Tj=25°C时电学特性(除非特别声明)

Parameter	Symbol Condit	Conditions		Value 值		Unit
参数	符号	条件	Min. 最小 值	Typ. 典型 值	Max. 最大 值	单位
Static Characteristic 静态特性						
Drain to Source Breakdown Voltage 漏极-源极击穿电压	BV <sub>DSS</sub>	$V_{GS}$ =0V, $I_{D}$ =100 $\mu$ A $T_{j}$ =25°C	1200	-	-	V
Zero Gate Voltage Drain Current 栅源-漏极漏电流	$I_{ m DSS}$	$V_{DS}$ =1200V, $V_{GS}$ =0V, $T_{j}$ =25°C	-	0.4	100	uA
Gate to Body Leakage Current 栅极-源极漏电流	$I_{GSS}$	V <sub>GS</sub> =18V, V <sub>DS</sub> =0V	-	-	200	nA
Static Drain-source On Resistance	D	$V_{GS}=18V, I_{D}=33A, T_{J}=25^{\circ}C$	-	40	60	mΩ
漏极-源极开通电阻	R <sub>DS(on)</sub>	$V_{GS}=18V, I_{D}=33A, T_{J}=175^{\circ}\text{C}$	-	68	-	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS}, I_{DS}=10mA$ $T_{J}=25^{\circ}\text{C}$	2.0	3.2	4.0	V
栅极-源极阈值电压		$V_{DS}=V_{GS}, I_{DS}=10 \text{mA}$ $T_J=175^{\circ}\text{C}$	-	2.3	-	
Gate Resistance 栅极电阻	$R_G$	f=1MHz, V <sub>AC</sub> =25mV	-	2.5	-	Ω
Dynamic Characteristic 动态特性						
Input Capacitance 输入电容	C <sub>iss</sub>		-	3009	-	
Output Capacitance 输出电容	$C_{oss}$	$V_{DD} = 1000V, \ f = 1MH_Z, V_{GS} = 0V, \ V_{AC} = 25mV$	-	182	-	pF
Reverse Transfer Capacitance 反向传输电容	$C_{rss}$	. Ac Zom	-	25	-	
Total Gate Charge 栅极总电荷	Qg(tot)		-	150	-	
Gate-source Charge 栅-源电荷	$Q_{\mathrm{gs}}$	V <sub>DD</sub> =800V, I <sub>D</sub> =40A, V <sub>GS</sub> =-5/20V	-	60	-	nC
Gate-Drain Charge 栅-漏电荷	$Q_{\mathrm{gd}}$		-	30	-	

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# Switching Characteristic at T<sub>j</sub>=25°C (Inductive Load)

Tj=25℃时开关特性(电感负载)

Parameter	Symbol	Conditions 条件	Value 值			Unit
Farameter 参数	· 符号		Min. 最小 值	Typ. 典型 值	Max. 最大 值	单位
MOSFET Characteristic MOSFET 特性			1			ı
Turn-on delay time 开通延迟时间	t <sub>d(on)</sub>	V <sub>DS</sub> =800V,	-	22	-	
Rise time 上升时间	$t_{\rm r}$	$V_{\rm DS}=800{\rm V},$ $V_{\rm GS}=-5/20{\rm V},$ $I_{\rm D}=40{\rm A},$	-	46	-	ng
Turn-off delay time 关断延迟时间	$t_{d(off)}$	$R_{G(ext)}=5\Omega,$ $R_{L}=20\Omega$	-	40	-	ns
Fall time 下降时间	${ m t_f}$		-	52	-	
Turn-on Switching Energy 开通损耗	Eon	$V_{DS}$ =800V, $V_{GS}$ =-5/20V, $I_{D}$ =40A,	-	1.3	-	mJ
Turn-off Switching Energy 关断损耗	Eoff	$R_{G(ext)}=5\Omega,$ $L=300\mu H$	-	0.8	-	
SOURCE-DRAIN DIODE CHARAC 源极-漏极二极管特性	CTERISTIC	CS				
Source to Drain Diode Forward Voltage	$ m V_{SD}$	$V_{GS}$ =-5V, $I_{SD}$ =20A, $T_{j}$ =25°C	-	3.4	-	V
源极-漏极正向电压	V <sub>SD</sub>	$V_{GS}$ =-5V, $I_{SD}$ =20A, $T_j$ =150°C	-	3.1	-	V
Continuous Diode Forward Current 正向电流	$I_{SD}$	T <sub>C</sub> =25°C	-	-	60	A
Reverse recovery time 反向恢复时间	$t_{ m rr}$	$T_j=25$ °C, $V_{GS}=-5$ V	-	50	-	ns
Recovered charge 恢复电荷	Qrr	$V_{R} = 800V,$ $I_{SD} = 40A,$	-	140	-	μС
Peak reverse recovery current 反向峰值电流	$I_{rrm}$	diF/dt=1200A/μs	-	5	-	A

#### Notes

a: Repetitive Rating: Pulse width limited by maximum junction temperature

b: Pulse Test : Pulse width ≤380µs

c: Essentially independent of operating temperature

注:

a: 重复范围: 脉冲宽度受限于最大结温

b: 脉冲测试: 脉冲宽度≤380μs

c: 本质上与工作温度无关

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### Electrical characteristics diagram 特性曲线

Figure 1. Output Characteristics  $T_J = -55^{\circ}C$ 

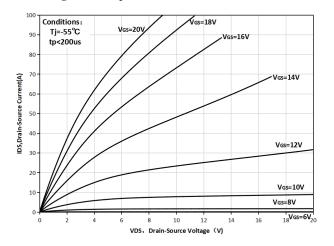


Figure 2. Output Characteristics  $T_J = 25^{\circ}C$ 

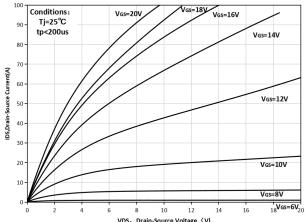


Figure 3. Output Characteristics T<sub>J</sub> =175°C

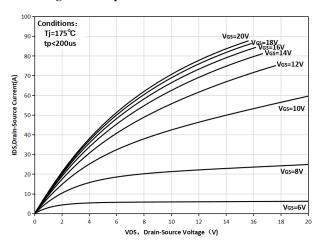


Figure 4. On-Resistance For Various Gate Voltage

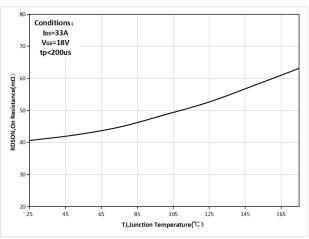


Figure 5. Transfer Characteristic for Various Junction Temperatures

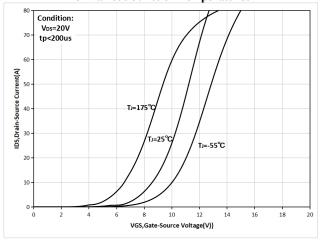
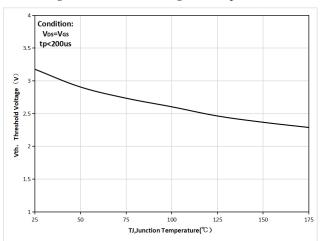


Figure 6. Threshold Voltage vs. Temperature



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Figure 7. Body Diode Characteristics at -55°C

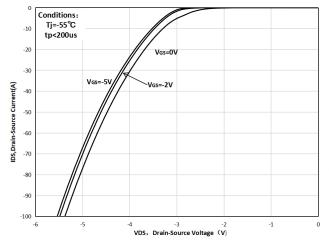


Figure 8. Body Diode Characteristics at 25°C

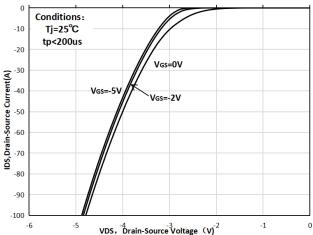


Figure 9. Body Diode Characteristics at 175℃

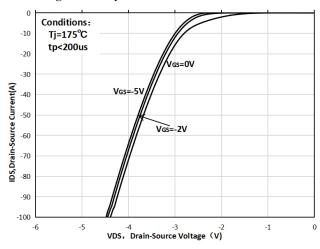


Figure 10. Capacitances vs. Drain-Source Voltage

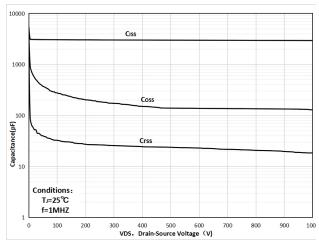


Figure 11. Gate Charge Characteristics

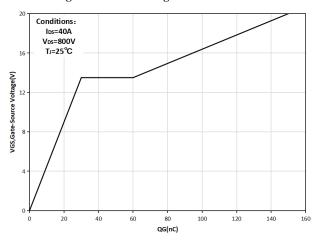
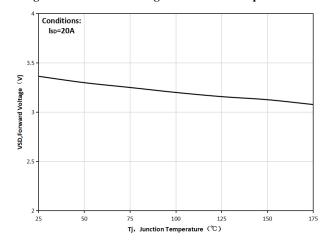


Figure 12. Forward Voltage vs.Junction Temperature



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Figure 13. Body Diode Characteristics for Various Junction Temperatures

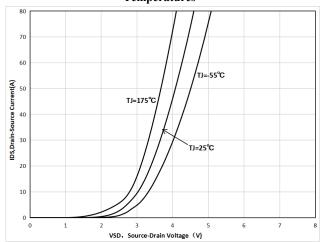


Figure 14. Clamped Inductive Switching Energy Vs.Temperature

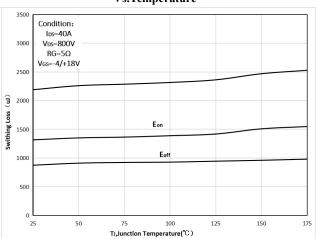


Figure 15. Switching Times vs. Junction Temperature

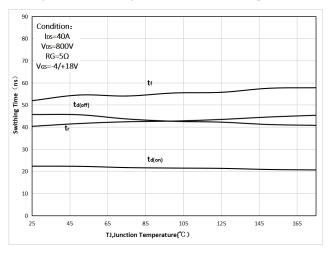


Figure 16. On-Resistance vs.Drain Current

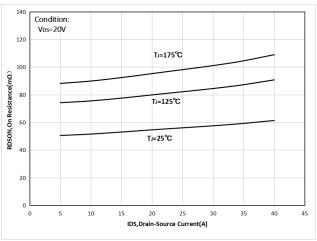
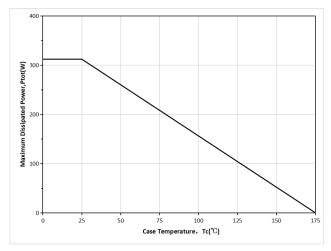
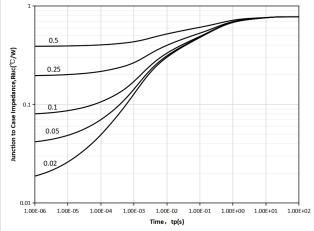


Figure 17. Power Dissipation Derating



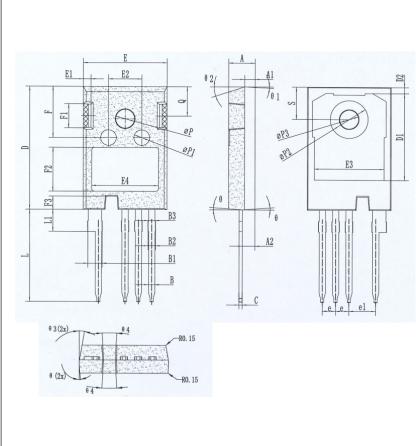
**Figure 18 Transient Thermal Impendance** 



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# TO-247-4 Packing Outline Dimensions: TO-247-4 封装外形尺寸



Dim.	Mechanical Dimensions /mm					
	MIN	NOM	MAX			
A	4.92	5.02	5.12			
A1	1.90	2.00	2.10			
В	1.15	1.20	1.25			
B1	2.50	2.65	2.80			
C	0.55	0.60	0.65			
D	23.25	23.45	23.65			
D1	16.35	16.55	16.75			
D2	1.02	1.17	1.32			
E	15.74	15.94	16.14			
E1	1.25	1.45	1.65			
F	9.55	9.75	9.95			
F1	4.40	4.60	4.80			
e	2.34	2.54	2.74			
el	4.88	5.08	5.28			
L	17.37	17.57	17.77			
L1	3.97	4.17	4.37			
ФР	3.70	3.80	3.90			
ФР1	2.90	3.00	3.10			
ФР2	7.10	7.20	7.30			
S	6.05	6.15	6.25			
Q	5.50	5.60	5.70			

Packing 包装

Package 包装	Pcs/tube	Tube/ inner box	Inner box/ carton	Pcs/carton
	个/管	管/内盒	内盒/外箱	个/箱
Tube 管	30	12	6	2160

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#### 产品使用注意事项

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